Microphotography of the light emitted by MSGCs operated in CF4

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Motivation

• The spatial distribution of the avalanche light in MSGC detectors with an optical readout has to be taken into account in light yield measurements.

It can also be used as a validity test for simulations.

 May lead to introduction of corrections in the Anger Camera event reconstruction algorithms.

 It can provide a generalization of the light emission patterns for different types of MSGC.



Setup



Max. magnification factor ~ 8 × \rightarrow 0.7×0.7 µm²/Px





How sharp these images can be?

Limitations imposed to the sharpness of the image

Optical aberrations

Lens diffraction (Airy disc)

Considering a lens only limited by diffraction

 $w \approx 0.42\lambda f/D \approx 1\mu m$

w: width of the Airy disc
λ: wavelength of the light (~ 600 nm)
f: focal distance of the lens (~ 90 mm)
D: aperture of the lens (20 mm)



Blurring > 1µm



Avalanche light

• 3 bar CF4

■ I ~ 80 nA





The irradiated area spanned ~16 anodes



Rough estimation of the relative intensity of the light emission from each anode

Each anode in the center contributes about 8% to the total collected light





At maximum amplification $\rightarrow 0.7 \times 0.7 \ \mu m^2/Px^2$



Light is emitted in the vicinity of the anodes



Emission profile along the anode length



The profile along the anode length reproduces the Bragg curve

Emission profile across the anodes

3 bar CF4 Several currents

~ 65% of the light is emitted directly above the anode, within a region of the same wide as the anode's surface.





3 bar CF4 field configuration 2



3 bar CF4 field configuration 3



2 bar CF4



2 bar CF4 + 2 bar He





Conclusions

- The avalanche light is localized at these operating conditions
- Most of the light is emitted directly above the anode, within a region of the same width as the anode's surface.
- The width of the emission region seems to be narrower in a He-CF4 mixture than in CF4 (at these operating conditions)
- For CF4 we saw no significant variation of the light profiles for different pressures or different field configurations

Next

- New lens system with increased resolution is now available
- It could be interesting to see the distribution of the avalanche light on a plane perpendicular to the microstrip surface.



Microphotography of the anode's surface after operation

Overview of the operating conditions

- Very high Anode Current > 80 nA
- The chamber was opened several times
- The pumping was relatively short
- No baking
- The presence of O₂, H₂0 was very likely

Material completely removed

Deposits in the glass most probably chromium oxides





Different colors may indicate different types of chromium oxides deposited on the anode surface 0



Damage along one anode



Lower current & less time











Question

Does long term operation leads to variations of the anode reflectivity?



The End

Microstrip: IMT, Masken und Teileungen AG

SN: 850771396

Pitch = 1 mm

Anode width = 10 μ m

Cathode width = 600 µm

